Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/602,638	HAN ET AL.
Examiner	Art Unit
Jaison Joseph	2611

	SEAR	CHED	
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375	229, 230 231,232	9/15/2006	IJ
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348	607, 614	9/15/2006	IJ
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SEARCH NO (INCLUDING SEARCH	TES I STRATEGY)
	DATE	EXMR
Inventor search	9/15/2006	JJ
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